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(12) **United States Design Patent**
Markovsky et al.

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- (54) **RECOGNITION TEST STRIP**
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- (73) Assignee: **Charm Sciences, Inc.**, Lawrence, MA (US)
- (**) Term: **14 Years**
- (21) Appl. No.: **29/408,364**
- (22) Filed: **Dec. 12, 2011**
- (51) **LOC (9) Cl.** **24-01**
- (52) **U.S. Cl.**
USPC **D24/225**
- (58) **Field of Classification Search**
USPC D24/216–217, 219, 222–226, 227, 231, D24/232, 107, 169, 186; D10/81; 422/400–404, 408, 430, 68.1, 56, 69, 422/500; 435/287.1, 287.3, 287.4, 288.1, 435/288.3, 288.7, 806
See application file for complete search history.

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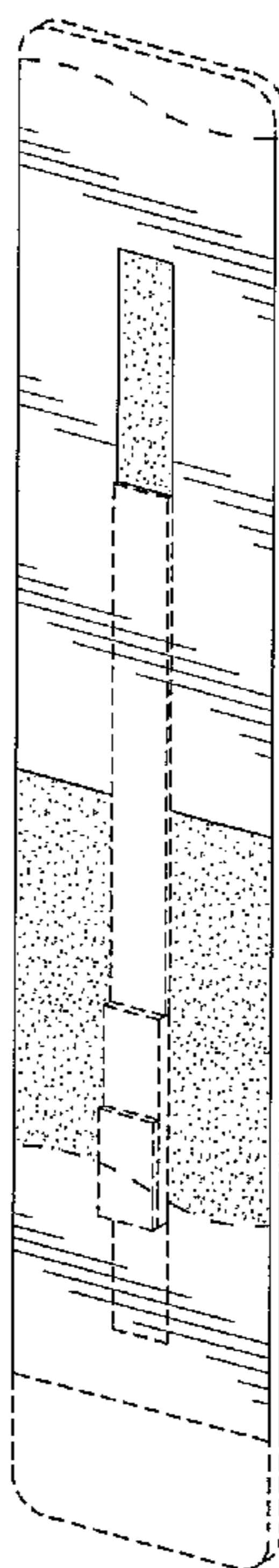
(57) **CLAIM**
The ornamental design for a recognition test strip, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of a recognition test strip; FIG. 2 is a front view thereof; FIG. 3 is right view thereof (the left view being a mirror image); FIG. 4 is an enlarged top plan view thereof (the opposite end view being a mirror image); and, FIG. 5 is an enlarged fragmentary rear view thereof. The broken lines in all views are included for the purpose of illustrating portions of the recognition test strip that form no part of the claimed design. The curved dashed lines in the drawing views are included to show the point at which the magnified view, FIG. 5, is cut and form no part of the claimed design.

1 Claim, 4 Drawing Sheets

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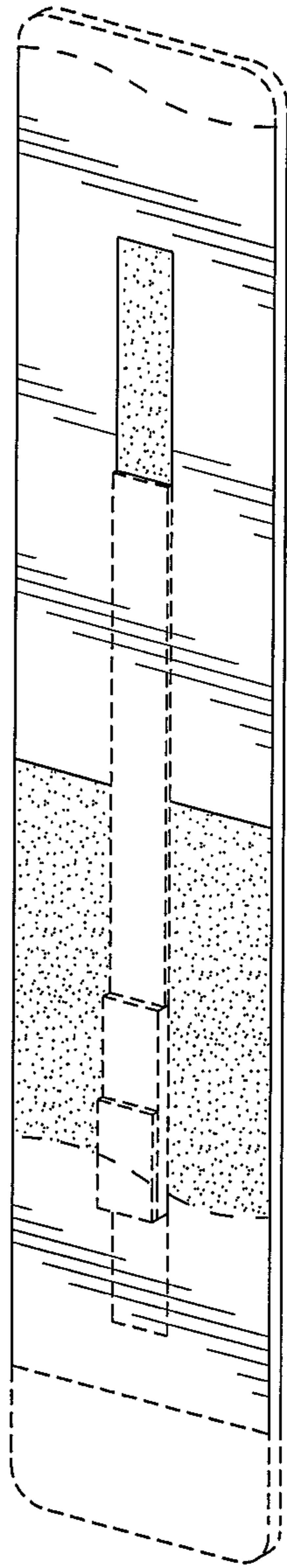


FIG. 1

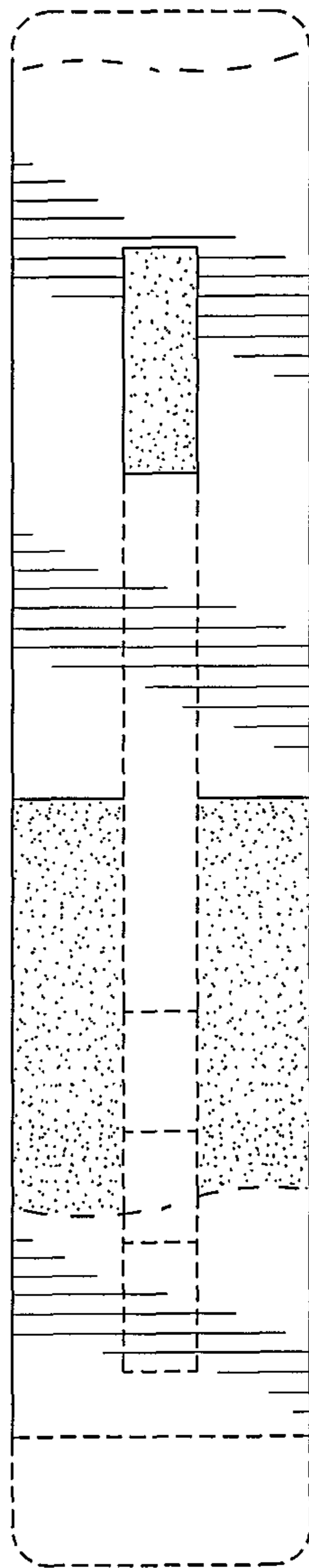


FIG. 2



FIG. 3

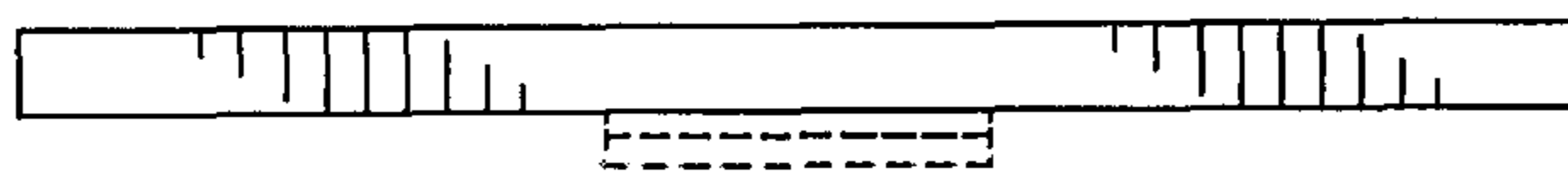


FIG. 4

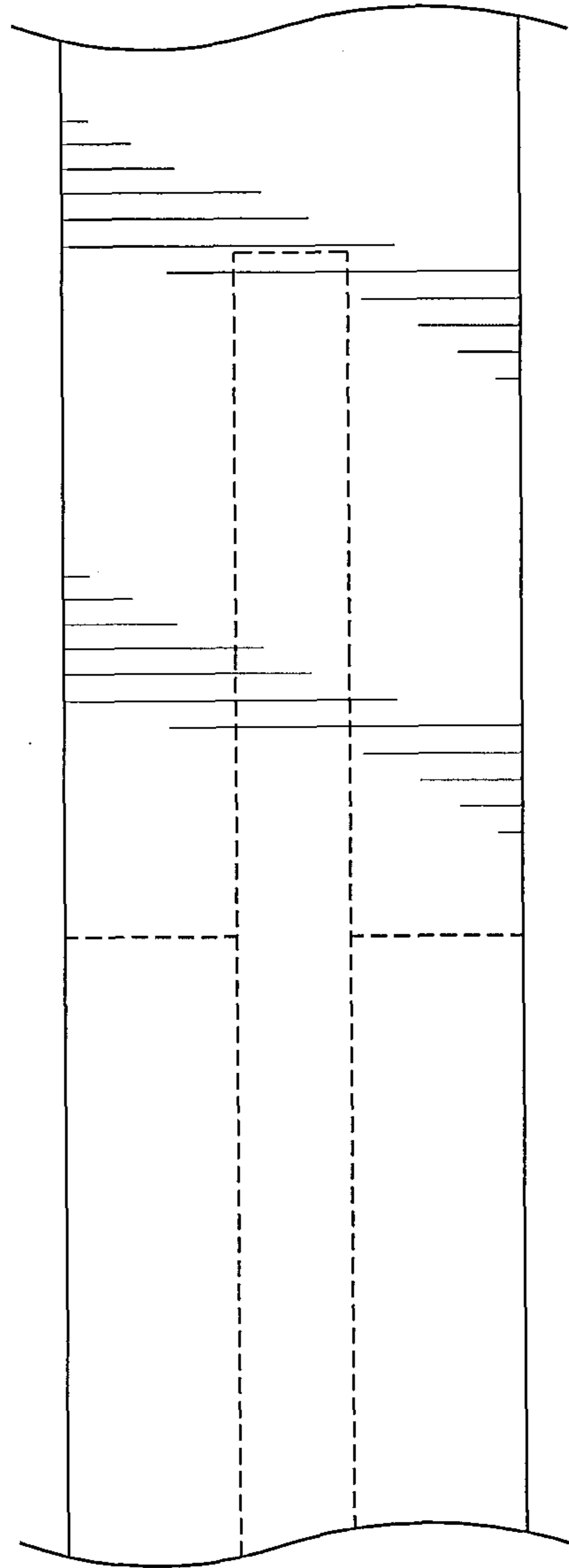


FIG. 5